Target Detection with Improved Image Texture Feature Coding Method and Support Vector Machine

R. Xu, X. Zhao, X. Li, C. Kwan, and C.-I Chang

Abstract—An image texture analysis and target recognition approach of using an improved image texture feature coding method (TFCM) and Support Vector Machine (SVM) for target detection is presented. With our proposed target detection framework, targets of interest can be detected accurately. Cascade-Sliding-Window technique was also developed for automated target localization. Application to mammogram showed that over 88% of normal mammograms and 80% of abnormal mammograms can be correctly identified. The approach was also successfully applied to Synthetic Aperture Radar (SAR) and Ground Penetrating Radar (GPR) images for target detection.

Keywords—Image texture analysis, Feature extraction, Target detection, Pattern classification

I. INTRODUCTION

A UTOMATIC Target Recognition (ATR) has many applications. One typical application is target detection in battlefield, such as the detection of moving people and vehicle, land mines, and weapon concealment. Besides military applications, one important objective of computeraided medical diagnosis in medical practices is to correctly detect anomalies in medical images such as mammogram, computer tomography, and magnetic resonance imaging.

A general image analysis-based ATR framework consists of target feature extraction, target pattern training, and target detection. Among them, feature extraction is considered as a very important part. Many research efforts have been conducted in this area in recent years, especially for target feature extraction by using image texture analysis [1]-[4] for target feature extraction as it has been observed that target textures are different from cluttered surroundings, which means target texture can help a lot on target detection.

All texture-based methods can be roughly classified into two categories: structural-based approach and statistical-based approach. In recent years, the statistical-based approach is attracting more research interests [5]-[12]. In current statistical-based methods, Texture Feature Coding Method (TFCM) is a new texture analysis scheme which transforms an original image into a texture feature image whose pixel values represent the texture information of the pixel in original image. The method has several remarkable advantages including accurate representation and record of target texture, and computational efficiency [11], [12]. For pattern training and target detection, Support Vector Machine (SVM) is a powerful tool to use, which is originated from modern statistical learning theory [13]. SVM is a kernel-based learning algorithm and relies on the borderline training samples to define the separation hyperplanes. Its performance is better than most other learning algorithms for a wide range of applications including automatic target recognition, image retrieval, and document analysis.

In this paper, we combine the TFCM-based feature extractors and the SVM-based pattern classifier into a unified package for ATR. With this proposed ATR system, the targets of interest in an input image can be efficiently detected. There are several distinctive advantages of this algorithm. First, a new target detection architecture (Texture feature extraction + SVM) is proposed, which combines the advantages of both TFCM and SVM. Second, the texture feature coding scheme in [12] is simplified to improve the computational efficiency. Third, two new TFCM-based feature extractors are developed. One is based on the principal eigenvector of the co-occurrence matrix of the texture feature numbers (TFN) and the other one is an augmented and much more efficient version of the one given in [12]. For the purpose of comparison, the texture feature number (TFN) histogram method for feature extraction [12] is also implemented. Fourth, with the extracted features, a robust and computationally efficient pattern classifier based on SVM is then trained and used for target detection. Fifth, a new technique called Cascade Sliding Window (CSW) is developed to perform automated target localization.

We have applied and evaluated the proposed ATR framework to different real life scenarios (different data sources), including mammogram, Synthetic Aperture Radar (SAR), and Ground Penetrating Radar (GPR) images.

The rest of this paper is arranged as follows. Section 2 summarizes all the technical methods, including the TFCM

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concept, three feature extractors (feature descriptors, TFN histogram, and principal eigenvector of the texture feature cooccurrence matrix), SVM classification method, and the CSW method for automatic target localization. Experimental results in mammograms, SAR images, and GPR images, are reported in Section 3 to demonstrate the efficiency of our proposed approach. Concluding remarks are given in Section 4.

II. ALGORITHM DESCRIPTION

A. Texture Feature Coding Method (TFCM)

For target detection in cluttered and complex environment, texture feature is considered as the major or only possible feature for target detection. Among the texture-based methods, texture feature coding method is well known for its efficiency. The concept of the TFCM [12] is derived from the gray-level co-occurrence matrix [14] and texture spectrum method [15]. In our proposed ATR approach, a simplified version of TFCM is developed to save more computation time. For better understanding, some key concepts of TFCM are briefly described as follows.

Fig. 1(a) shows a 3x3 window mask over a pixel, in which there are eight orientations, 0°, 45°, 90°, 135°, 180°, 225°, 270°, and 315°. Fig. 1(b) shows a 4-neighbor connectivity of a pixel X with four pixels labeled as 1, 3, 5, and 7 which are referred as first-order neighboring pixels. The additional four pixels labeled as 2, 4, 6, and 8, and located along two diagonal lines are referred as second-order neighboring pixels as shown in Fig. 1(c).



Fig. 1 First-order and second-order 4-neighbor connectivity

TFCM considers three consecutive pixels along these specific directions (called scan lines), and calculates gradient changes in gray levels among these three pixels [12]. We denote the three consecutive pixels by their spatial coordinates at *a*, *b*, *c*, associate its gray level by I(a), I(b) and I(c) respectively, and let Δ be a desired gray level tolerance. There are four types of successive gradient changes in gray level with their corresponding graphic descriptions given in

Fig. 2.
(i)
$$|I(a) - I(b)| \le \Delta$$
, $|I(b) - I(c)| \le \Delta$
(ii) $|I(a) - I(b)| \le \Delta$, $|I(b) - I(c)| > \Delta$ or
 $|I(a) - I(b)| > \Delta$, $|I(b) - I(c)| \le \Delta$ (1)



Fig. 2 Types of gray-level graphical structure variations

If we introduce a pair of integers (v, w) to represent the gray-level variations of first-order and the second-order connectivity respectively, and consider the symmetry between first scan line and second scan line of first-order or second order connectivity, the number of each connectivity combinations can be reduced to 4*(4+1)/2=10, as shown in Table 1. In the conventional method [12], Table 1 is coded in a discrete way from 1 to 23 according to the definition given in [15]. Then, for the pair of integers (v, w) of any image pixel, its texture feature number (TFN) can be computed as TFN(x, y).

$$TFN(x, y) = \alpha(x, y) \times \beta(x, y)$$
(2)

where $\alpha(x, y)$ and $\beta(x, y)$ are the values obtained from Table 1. According to Eq. (2), the number range is from 1 to 529, but only 55 are actually used for texture feature coding. Therefore, to save computational cost and memory space, we compress the set of 1 to 529 to 0 to 54 values by removing unused texture feature numbers.

First scan line (i) (ii) (iii) (iv) Second 2 3 5 1 (i) scan line (ii) 2 7 11 13 3 11 17 19 (iii) 5 13 19 23 (iv)

TABLE I COMBINATION CODING OF THE GRAY-LEVEL VARIATIONS (I)

Unlike the coding scheme mentioned above, we use continuous numbers to code the cases shown in Table 2. With the new table, for each gray-level variation (v, w) of an image pixel we can directly compute the TFNs, which are listed in Table 3. If we ignore the difference between the first order and the second order connectivity, we can find the texture feature number $TFN_{\Delta}(x, y)$, of the pixel at location (x, y) according to Table 3. In this way, the computation time of (a,b) is greatly reduced. That is, a simple table look-up is enough to generate the TFNs.

TABLE II	
COMBINATION CODING OF THE GRAY-LEVEL	VARIATIONS (II)

		F	First scan lin	e	
Second		(i)	(ii)	(iii)	(iv)
scan line	(i)	1	2	3	4
	(ii)	2	5	6	7
	(iii)	3	6	8	9
	(iv)	4	7	9	10

TABLE III TEXTURE FEATURE NUMBER GENERATION TABLE BASED ON THE NEW CODING SCHEME

			11		DING	JOHLIN	IL			
	1	2	3	4	5	6	7	8	9	10
1	0	1	2	3	4	5	6	7	8	9
2	1	10	11	12	13	14	15	16	17	18
3	2	11	19	20	21	22	23	24	25	26
4	3	12	20	27	28	29	30	31	32	33
5	4	13	21	28	34	35	36	37	38	39
6	5	14	22	29	35	40	41	42	43	44
7	6	15	23	30	36	41	45	46	47	48
8	7	16	24	31	37	42	46	49	50	51
9	8	17	25	32	38	43	47	50	52	53
10	9	18	26	33	39	44	48	51	53	54

It is worth to mention that our new coding scheme has three unique properties. First, the $TFN_{\Delta}(x, y)$ is quasi-rotationinvariant because symmetry is considered during coding. Second, since $TFN_{\Delta}(x, y)$ only takes a value ranging from 0 to 54, the calculation of a TFCM based co-occurrence matrix of an image and some of its corresponding TFCM features will take less time. Third, the code value at a given pixel represents the coarseness of its neighborhood. The higher the code value is, the more gray-level variation its corresponding pixel possesses. All the aforementioned properties are very important as they capture the essence of the texture around a specific pixel.

Once a TFN feature image is obtained by TFCM, two measures based on TFN histogram and TFCM-based Cooccurrence matrix, can be computed and used to characterize its statistics. A TFN histogram is defined as

$$p_{TFN,\Delta}(n) = \frac{N_{TFN,\Delta}(n)}{\sum_{n=0}^{54} N_{TFN,\Delta}(n)}$$
(3)

where $N_{TFN,\Delta}(n)$ is the total number of $TFN_{\Delta}(x, y)$ in the image taking value *n* and Δ is the grav-level variation

image taking value n, and Δ is the gray-level variation tolerance given in Eq. (1). The TFN based co-occurrence matrix, which is a probability distribution of transitions between any pair of arbitrary two TFNs, can be defined as

$$p_{\Delta}(i,j \mid d,\theta) = \frac{N_{\Delta,d,\theta}(i,j)}{\sum_{l,k} N_{\Delta,d,\theta}(l,k)}$$
(4)

where $N_{\Delta,d,\theta}(i, j)$ is the number of pairs of two pixels at spatial locations (x, y) and (w, z) satisfying TFN code level I(x,y) = i, I(w,z) = j and *d*-pixel apart along angular rotation θ and $\sum_{l,k} N_{\Delta,d,\theta}(l,k)$ is the total number of TFN transitions.

B. Texture Feature Extraction

Based on the TFN histogram and TFCM-based Cooccurrence matrix, two new feature extractors were developed. One is named as eigenvector-based feature extraction and another one called statistical analysis-based method is an augmented and more computationally efficient version of the one given in [12]. For comparison, one traditional feature extractor, called TFN histogram, was also implemented. All the details are discussed as follows.

• TFN histogram

The TFN histogram introduced by [12] has 55 dimensions to each image or region of interest, and can be used directly as feature descriptors independently as it contains rich texture information of the image or the region of interest. The definition of TFN histogram is given in Eq. (3). An example of TFN histogram on a mammogram image is given in Fig. 3.





(c) TFN histogram Fig. 3 TFN histogram of a mammogram image

• Statistical Texture Feature Descriptors

In order to capture the essence of texture information of an image, a set of texture feature descriptors was developed to represent the kernel texture information of the image or the region of interest. Here we introduce eleven descriptors. Some of them (1 to 8) were already discussed in [12], [16], the other three (9-11) are specially designed by us.

The first two feature descriptors are derived from the TFN histogram of an image.

1. Mean convergence

$$MC = \sum_{n=0}^{54} \frac{\left| n \cdot p_{\Delta}(n) - \mu_{\Delta} \right|}{\sigma_{\Delta}}$$
(5)

where μ_{Δ} , σ_{Δ} are the mean and variance of the histogram, respectively. p_{Δ} is defined in Eq. (4).

2. Code variance 54

$$Var = \sum_{n=0}^{54} (n - \mu_{\Delta})^2 \cdot p_{\Delta}(n)$$
(6)

The remaining feature descriptors are based on the TFN cooccurrence matrix. Here we fix d = 1 and use the average of four matrices (corresponding to $\theta = 0$, $\theta = 45^{\circ}$, $\theta = 90^{\circ}$ and $\theta = 135^{\circ}$). That is,

$$P_{\Delta,d} = \frac{1}{4} \left(P(d=1,\theta=0^{\circ}) + P(d=1,\theta=45^{\circ}) + P(d=1,\theta=90^{\circ}) + P(d=1,\theta=135^{\circ}) \right)$$

where $P(d,\theta)$ is the TFN co-occurrence matrix with respect to *d* and θ . Based on $P_{\Delta,d}$, we define the following features 3. Code entropy

$$CE = \sum_{i=0}^{54} \sum_{j=0}^{54} p_{\Delta,d}(i,j) \log p_{\Delta,d}(i,j)$$
(7)

4. Uniformity

$$UN = \sum_{i=0}^{54} \sum_{j=0}^{54} p_{\Delta,d}^2(i,j)$$
(8)

5. First-order element difference moment (FDM)

$$FDM = \sum_{i=0}^{54} \sum_{j=0}^{54} |i - j| p_{\Delta,d}(i, j)$$
(9)

6. Second-order element difference moment (SDM)

FID

$$SDM = \sum_{i=0}^{54} \sum_{j=0}^{54} (i-j)^2 p_{\Delta,d}(i,j)$$
(10)

7. First-order inverse element difference moment (FIDM)

$$M = \sum_{i=0}^{54} \sum_{j=0}^{54} \frac{1}{1+|i-j|} p_{\Delta,d}(i,j)$$
(11)

8. Second-order inverse element difference moment (SIDM)

$$SIDM = \sum_{i=0}^{54} \sum_{j=0}^{54} \frac{1}{1 + (i-j)^2} p_{\Delta,d}(i,j)$$
(12)

The following three features are the region-based features of the co-occurrence matrix.

9. to 11. Energy Distributions of Co-occurrence Matrix

$$SB1 = \sum_{i=44}^{54} \sum_{j=44}^{54} p_{\Delta,d}(i,j)$$
(13)

$$SB2 = \sum_{i=34}^{54} \sum_{j=34}^{54} p_{\Delta,d}(i,j) - SB1$$
(14)

$$SB3 = \sum_{i=14}^{54} \sum_{j=14}^{54} p_{\Delta,d}(i,j) - SB1 - SB2$$
(15)

The summation regions (SB1, SB2, and SB3) are depicted in Fig. 4. In this way, the energy distributions of texture for different regions are being considered and added into the feature vector. Compared with the feature vector without energy distribution component, the feature vector with energy distribution can provide an additional 5% -10% increase in target recognition rate according to our tests.



Fig. 4 Summation regions of different subband probabilities.

As a result of the above operators, each image or the region of interest in the database can be represented by an 11 x 1 feature vector. Since some features usually have large magnitudes and the others have small magnitudes, we scale different feature elements such that each feature contributes equally to the classifier

Principal eigenvector of the TFN based co-occurrence matrix

The 55x55 TFN co-occurrence matrix called *P* can be computed via Eq. (4) to an image or the region of interest. After performing eigenvalue decomposition on $R=PP^{T}$, we found that, in most cases, the largest eigenvalue of *R* is larger than 85% of the sum of all the other eigenvalues of *R*. This means the 55 dimensional principal eigenvector of a TFN cooccurrence matrix, corresponding to its largest eigenvalue, may also well represent the texture properties of the image. It can either be feature vector independently or combined with the histogram feature vector. In one of our studies, we cascade the TFN histogram vector and the principal eigenvector to form a new 110 dimensional feature vector. With this newly developed feature set, we can achieve a good classification result in some conditions (See Section 3), which has, in return, validated our reasoning logic.

C. Support Vector Machine (SVM) for Classification

According to the references [17], [18], SVM parameters are computed by solving a quadratic programming problem with linear equality and inequality constraints; rather than by solving a non-convex, unconstrained optimization problem. The flexibility of kernel functions allows the SVM to search a wide variety of hypothesis spaces. The geometrical interpretation of support vector classification can be thought as the optimal separation on feature surface. A simple example of 2-D data classification with three different classes using SVM is shown in Fig. 5, wherein the optimal boundaries are found between each pair of classes. The advantages of SVM include:

- It is a quadratic learning algorithm; hence, there are no local optima. It can also be formed as linear programming for simplicity.
- Statistical theory gives bounds on the expected performance of a support machine.
- Performance is better than most other learning algorithms for a wide range of applications including automatic target recognition, and document classification
- Although originally designed for 2-class classification, SVMs have been effectively extended to multi-class classification applications. Algorithms, such as One-against-one, DAG, one-against-all, and C&S, have been successfully applied to multi-target recognition.
- There is no over-training problem as compared to conventional learning classifiers such as neural net or fuzzy logic.



Fig. 5 SVM classification results of three classes

The TFCM-SVM training and testing procedures based on the statistical feature descriptors are briefly summarized below:

- 1. Prepare *M* training images with known ground truth, which means we have already known which image is background image and which image is target image and the target type. Associate each image with an integer class label, for example, 0, 1, 2, ..., *M*.
- 2. Perform TFCM on each image to obtain a feature image with its element being TFN numbers.
- 3. Calculate a TFN histogram for each feature image.
- 4. Calculate a TFCM co-occurrence matrix for the same feature image
- 5. Calculate the 11 texture feature descriptors using Eqs. (5) to (15) to represent the image being processed
- 6. Form all the image feature vectors into a 11xM matrix, regarded as the input matrix. Align their class labels to a 1xM row output vector.
- 7. Use the input and output pair to train the SVM. The result is stored in a set of vectors and matrices.

In the testing stage, the first six steps are still applicable to a testing image. Compared with the training stage the difference is the trained support vector machine is used to output a label vector for a testing image at the last step (Step 7). Note that the TFCM-SVM procedures, either based on TFN histogram or principal eigenvector, have the similar steps as statistical feature descriptor-based method.

D. Automatic Target Localization and Detection

In order to localize and detect a target automatically, a Cascade Sliding Window (CSW) technique was developed. The key idea of the technique is to segment the whole image by a $N \times N$ pixel window and train the TFCM-SVM by using both the background/normal regions and the target regions. *N* is a predetermined value. In our experiments, the value of *N* is twice the size of the possible targets. To test a new image, the $N \times N$ pixel window moves around the image and feeds the segmented image into the TFCM_SVM for classification. The flowchart diagram of CSW is illustrated in Fig. 6.



Fig. 6 Flow chart of the TFCM-SVM-CSW algorithm

III. EXPERIMENTAL RESULTS

A. Mammogram Inspection

Our first case study was focused on mammogram inspection by using TFCM-SVM method. The database is the MiniMammographic Database provided by the Mammographic Image Analysis Society (MIAS). In our study, 59 normal mammogram images and 55 abnormal images containing different abnormalities were segmented from the database (totally 114 images). The abnormal regions were classified into the following 5 abnormal categories:

- 13 in architectural distortions (ARCH),
- 10 in asymmetry tissues (ASYM),
- 12 in circumscribed masses (CRIC),
- 11 in speculate masses (SPEC),
- 9 in other/ill-defined masses (MISC).

In our tests, we ran the TFCM method first to some randomly selected images from the above five categories as shown in Fig. 7, and some selected normal images as shown in Fig. 8. All normal images are 128x128 in size whereas the image size for the abnormal images varies as the area of the abnormal region differs from one case to another. After obtaining the features of all selected images, we used SVM with RBF (Radial Basis Functions) kernel to perform target classification.

The cross validation method, also known as leave-one-out scheme, was used for training and testing. In this method, the decision rule is first obtained by using all but one of the samples in the data set, and the sample which is left out is then used to test the performance of the decision rule. This procedure is repeated for all the samples in the data set. For example, if there are I normal data and K abnormal data, then I+K classification results can be obtained by this method. From these we can obtain an estimate of the overall accuracy of the classification scheme. The results of our tests were summarized in from Table 4. It can be seen that the TFCM-SVM with eigenvector has the best performance. Note that the leave-one-out is only suitable for off-line training and testing. The result by using CSW to a large image (1024x1024) which contains multiple abnormal regions is given in Fig. 9 to demonstrate the efficiency of our approach on automatic

target detection and classification in online stage, wherein the yellow ellipsis is known as ground truth and the red rectangles are the detected targets.

The performance of SVM is affected by two parameters, namely the kernel parameter γ and the regularization parameter C. For a given regularization parameter C, larger kernel parameter γ leads to smaller training error. The tradeoff is the generalization capability of the SVM will be reduced. If γ becomes too small, the two classes would be too close to each other, and the performance will also be degraded. In short, there is an optimal combination of the two SVM parameters, which can be obtained through trial-anderror. Some studies on parameter tuning with feature descriptor-based TFCM-SVM method are given in Table 5 and Table 6.

In Table 5, we fixed C as 100, and showed the results with $\gamma = 10^{-3}$, $\gamma = 10^{-4}$, and $\gamma = 10^{-5}$, respectively. The cross validation method was used in the training and test. It can be seen that the best classification result was obtained with $\gamma = 10^{-4}$. In this case, the algorithm yields 90% correct detection for normal data and 80% correct classification for abnormal data. The overall correct detection rate is 85%. We then fixed γ as $\gamma = 10^{-4}$ and varied the value of C to repeat the test. The results are shown in Table 6, in which the best performance is obtained at $C = 10^4$ and $\gamma = 10^{-4}$. Although the classification performance of normal data is slightly reduced, the performance on abnormal data is improved, and the overall correct classification rate increases to 87%.

B. Target Detection in Airborne SAR Images

In this study, we applied the TFCM-SVM method to SAR images for target detection. The image we used is shown in Fig. 10. The unclassified raw image (size 765x765) was supplied by the U.S. Army. The image shown in Fig. 10 is filtered by a 5x5 median filter [4] to eliminate some noise spikes. A median filter is a rank filter which, for a given vector of data points, first sorts the points from smallest to largest, and then picks the median value as the filter output.

We selected 9 regions of background and 10 regions of target in the experiment. Each region has a size of 64 x 64 pixels. These chosen regions are shown in Fig. 11and Fig. 12.

The cross validation method was used again. That is, each time we used all but one sample for training, then tested with the remaining ones. The procedure was then repeated for all samples. The results were summarized in Table 7, where the value of Δ was chosen as 3 in texture feature coding. Table 7 also shows that the eigenvector approach can achieve 100% accuracy for background data and 90% accuracy on target detection.



PERFORMAN	PERFORMANCE OF IFCM-SVM TO MAMMOGRAM IMAGES WITH C = 100 AND 7					
Feature Type	Training data: Correct Rate	Testing data: Correct Detection Rate of Normal Data	Testing data: Correct Detection Rate of Abnormal Data			
Feature Descriptors	85%	50/59=85%	40/55=73%			
Histogram	84%	49/59=83%	42/55=76%			
Eigenvector	89%	50/59=85%	35/55=64%			
Histogram and Eigenvector	92%	52/59=88%	44/59=80%			

PERFORMANCE OF TFCM-SVM TO MAMMOGRAM IMAGES WITH $C = 100$ AND γ –	. 1
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Fig. 9 Anomaly detection and localization in mammograms with CSW

	TABLE V		
PERFORM	JANCE OF TECM-SVM	WITH $C = 100$	
		0 100	
Training data:	Testing data:	Testing data:	-
. 0	0	0	

γ	Training data:	Testing data:	Testing data:	Testing data:
	Correct Rate	Correct Detection Rate	Correct Detection Rate	Overall Correct
		of Normal Data	of Abnormal Data	Detection Rate
1E - 3	94 %	47/59=80%	39/55=71%	86/114=75%
$1E$ Λ	89 %	53/59=90%	44/55=80%	97/114=85%
1L = 4	84%	53/59=90%	39/55=71%	92/114=81%
1E - 5	01/0		59,660 (11)0	<i>y</i> 2 /111 01/0

TABLE VI

PERFORMANCE OF TFCM-SVM WITH $\gamma = 10^{-4}$

С	Training data: Correct Rate	Testing data: Correct Detection Rate	Testing data: Correct Detection Rate	Testing data: Overall Correct
		of Normal Data	of Abnormal Data	Detection Rate
1 <i>E</i> 3	93%	52/59=88%	45/55=82%	97/114=85%
1E4	97%	52/59=88%	47/55=85%	99/114=87%
1 <i>E</i> 5	100%	52/59=88%	44/55=80%	96/114=84%



(a) Raw image



(b) Median filtered image

Fig. 10 A SAR image



Fig. 11 Background data set

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Fig. 12 Target data set

TABLE VII

PERFORMANCE OF TFCM-SVM IN SAR IMAGE WITH C = 100 and $\gamma = 1$

Training Correct	Correct	Correct Detection
Rate	Detection Rate	Rate of Abnormal
	of Normal	(Target) Data
	(Background)	
	Data	
90%	6/9=67%	9/10=90%
87%	5/9=56%	9/10=90%
100%	9/9=100%	9/10=90%
100%	8/9=89%	8/10=80%
	Training Correct Rate 90% 87% 100% 100%	Training Correct Correct Rate Detection Rate of Normal (Background) Data Data 90% 6/9=67% 87% 5/9=56% 100% 9/9=100% 100% 8/9=89%



Fig. 13 Experimental setup: (a) the sandbox (b) Ground penetration radar (c) ground truth of the buried mines and other objects (obtained from Department of Electronics & Information Processing, Vrije University)

C. Mine Detection in Ground Penetrating Radar Images

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Besides mammogram classification, the CSW technique described earlier was also applied to mine detection. The GPR minefield image data were obtained from the Department of Electronics & Information Processing of Vrije University. The acquisition was performed in dry clay mixed with small rocks. The GPR settings for this scan were 10 averages per A-scan, 25 ps sampling interval, 512 samples, 1 GHz antenna, and 1 ns pulse width. An area of dx = 50 cm by dy = 196 cm was scanned with a scanning step of 1 cm in each direction. The surface was not flattened before the scan. There were irregularities with a maximum of 20 cm between the highest and the lowest point. The antenna head was placed at 5 cm above the highest point, and the scan was done horizontally. The experimental setup and the ground truth diagram are shown in Fig. 13.

Three C-scan images of Dry-clay field with two mines buried 5 cm under the ground and one image without mines are shown in Fig. 14. Similarly, we mark the abnormal region with a yellow ellipsis as ground truth and red frames as detected mine by TFCM-SVM-CSW method. The results are shown in Fig. 15, which indicates that our algorithm can successfully detect those two mines captured from different layers in a dry clay field. Further improvement is still needed for more accurate target location. Due to the limited available data, we could not generate statistical results for GPR data. However, the target detection and location algorithm can correctly detect and localize all the targets in the available images.



Normal without mine Layer_1 Layer_2 Layer_3 Fig. 14 Normal field and three C-scan images captured at different



IV CONCLUSION

A novel and computationally efficient framework using texture feature coding-based descriptors and support vector machines for target detection is presented. Our contributions can be summarized as follows. First, a new automatic target detection structure which consists of TFCM-based feature extraction, support vector machines, and Cascade-Sliding-Window is designed. Second, the original texture feature coding scheme is simplified and improved to save computational cost. Third, two new TFCM-based feature extraction methods have been developed. Fourth, the efficient pattern training and classification method (SVM method) is proposed and integrated into our ATR system. Finally, Cascade-Sliding-Window approach is developed for automated target localization. Preliminary tests on mammogram show over 88% of normal mammograms and 80% of abnormal mammograms are correctly identified without parameter tuning. The test results in SAR and GPR images are also satisfactory

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